

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10656260	TABU, TOSHIYUKI
	Examiner	Art Unit
	GERMAN VIANA DI PRISCO	2617

SEARCHED

Class	Subclass	Date	Examiner
370	389, 392	5/7/2008	GV
See application file for complete search history		12/18/2008	GV

SEARCH NOTES

Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	5/7/2008	GV
Inventor name and Assignee search in PALM ExPO and EAST	5/7/2008	GV
EPO Database(http://ep.espacenet.com)	5/7/2008	GV
Consulted with Rafael Perez-Gutierrez , Ken Vanderpuye and Duc Nguyen	5/7/2008	GV
Updated search	12/18/2008	GV

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
See interference search in search history		12/18/2008	GV